

**Search Notes**

Application/Control No.

10/701,249

Examiner

Tuyen To

Applicant(s)/Patent under  
Reexamination

ICHIMIYA, JUNJI

Art Unit

2825

TT

**SEARCHED**

Class	Subclass	Date	Examiner
716	10	2/17/2006	TT
716	9,12-14	2/17/2006	TT
716	11	2/17/2006	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	9	2/17/2006	TT
716	11	2/17/2006	TT
716	12-14	2/17/2006	TT
Interference search. See the attached search printout		2/17/2006	TT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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